



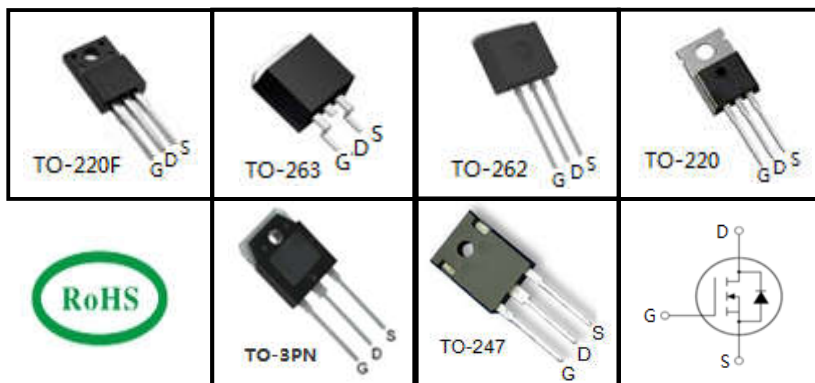
650V Super-Junction Power MOSFET

FEATURES

- Very low FOM $R_{DS(on)} \times Q_g$
- 100% avalanche tested
- RoHS compliant

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)



Device Marking and Package Information

Device	TPA65R260M	TPB65R260M	TPC65R260M	TPP65R260M	TPV65R260M	TPW65R260M
Package	TO-220F	TO-263	TO-262	TO-220	TO-3PN	TO-247
Marking	65R260M	65R260M	65R260M	65R260M	65R260M	65R260M

Absolute Maximum Ratings $T_C = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Value		Unit
		TO-263, TO-262, TO-220 TO-3PN, TO-247	TO-220F	
Drain-Source Voltage ($V_{GS} = 0V$)	V_{DSS}	650		V
Continuous Drain Current	I_D	$T_C = 25^\circ\text{C}$	15	A
		$T_C = 100^\circ\text{C}$	9	
Pulsed Drain Current (note1)	I_{DM}	45		A
Gate-Source Voltage	V_{GSS}	± 30		V
Single Pulse Avalanche Energy (note2)	E_{AS}	290		mJ
Avalanche Current (note1)	I_{AR}	2.4		A
Repetitive Avalanche Energy (note1)	E_{AR}	0.44		mJ
MOSFET dv/dt ruggedness, $V_{DS} = 0 \dots 480V$	dv/dt	50		V/ns
Reverse diode dv/dt, $V_{DS} = 0 \dots 480V$, $I_{SD} \leq I_D$	dv/dt	15		V/ns
Power Dissipation ($T_C = 25^\circ\text{C}$)	P_D	105	32	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	$-55 \sim +150$		$^\circ\text{C}$

Thermal Resistance

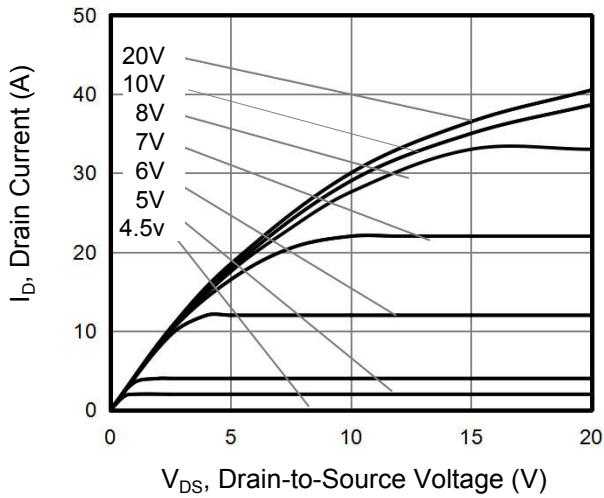
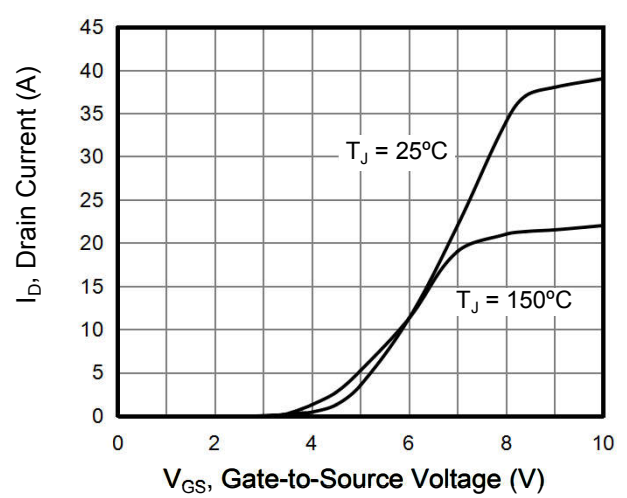
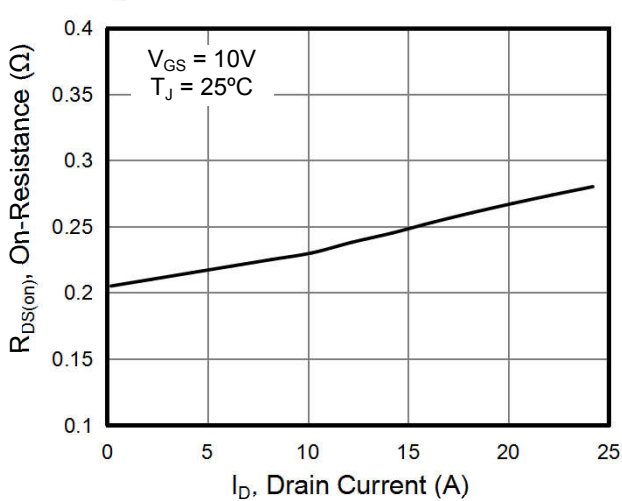
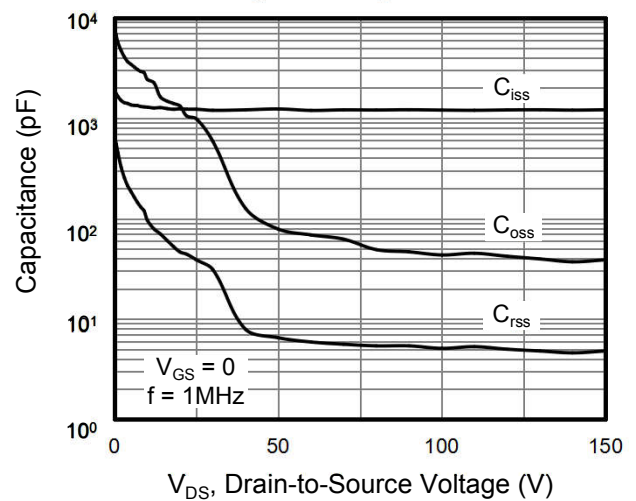
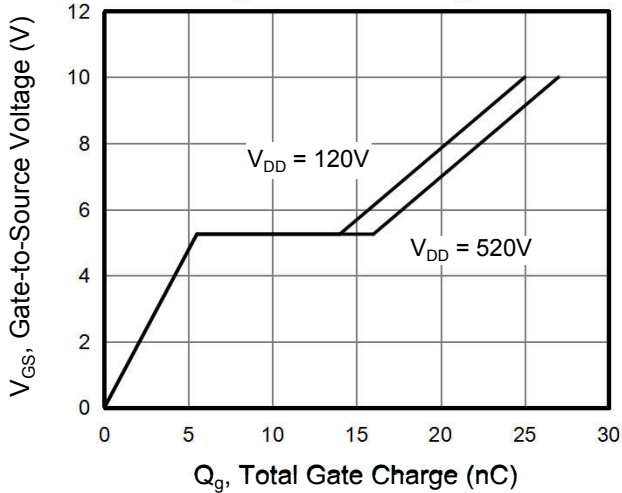
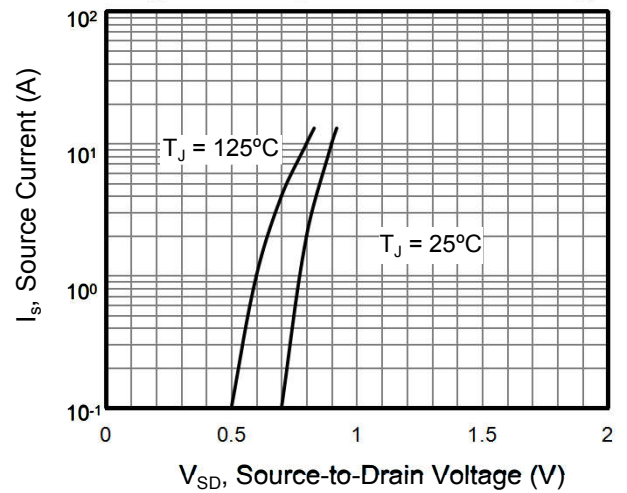
Parameter	Symbol	Value		Unit
		TO-263, TO-262, TO-220 TO-3PN, TO-247	TO-220F	
Thermal Resistance, Junction-to-Case	R_{thJC}	1.2	3.9	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient	R_{thJA}	62	80	



Specifications T _J = 25°C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
Static						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	650	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 650V, V _{GS} = 0V, T _J = 25°C	--	--	1	μA
		V _{DS} = 650V, V _{GS} = 0V, T _J = 150°C	--	--	100	
Gate-Source Leakage	I _{GSS}	V _{GS} = ±30V	--	--	±100	nA
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	2.5	--	4.5	V
Drain-Source On-Resistance (Note3)	R _{DS(on)}	V _{GS} = 10V, I _D = 7.5A	--	0.24	0.26	Ω
Forward Transconductance (Note3)	R _G	f = 1.0MHz open drain	--	12.5	--	S
Dynamic						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 100V, f = 1.0MHz	--	1202	--	pF
Output Capacitance	C _{oss}		--	43	--	
Reverse Transfer Capacitance	C _{rss}		--	5	--	
Total Gate Charge	Q _g	V _{DD} = 520V, I _D = 15A, V _{GS} = 10V	--	27	--	nC
Gate-Source Charge	Q _{gs}		--	5.5	--	
Gate-Drain Charge	Q _{gd}		--	10.5	--	
Turn-on Delay Time	t _{d(on)}	V _{DD} = 400V, I _D = 15A, R _G = 25Ω	--	25	--	ns
Turn-on Rise Time	t _r		--	63	--	
Turn-off Delay Time	t _{d(off)}		--	100	--	
Turn-off Fall Time	t _f		--	50	--	
Drain-Source Body Diode Characteristics						
Continuous Body Diode Current	I _S	T _C = 25°C	--	--	15	A
Pulsed Diode Forward Current	I _{SM}		--	--	45	
Body Diode Voltage	V _{SD}	T _J = 25°C, I _{SD} = 15A, V _{GS} = 0V	--	0.9	1.2	V
Reverse Recovery Time	t _{rr}	V _R = 400V, I _F = I _S , di _F /dt = 100A/μs	--	410	--	ns
Reverse Recovery Charge	Q _{rr}		--	4.1	--	μC
Peak Reverse Recovery Current	I _{rrm}		--	20	--	A

Notes

1. Repetitive Rating: Pulse Width limited by maximum junction temperature
2. $I_{AS} = 2.4A, V_{DD} = 50V, R_G = 25\Omega$, Starting $T_J = 25^{\circ}\text{C}$
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 1\%$

**Typical Characteristics** $T_J = 25^\circ\text{C}$, unless otherwise noted**Figure 1. Output Characteristics****Figure 2. Transfer Characteristics****Figure 3. On-Resistance vs. Drain Current****Figure 4. Capacitance****Figure 5. Gate Charge****Figure 6. Body Diode Forward Voltage**



Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Figure 7. On-Resistance vs. Junction Temperature

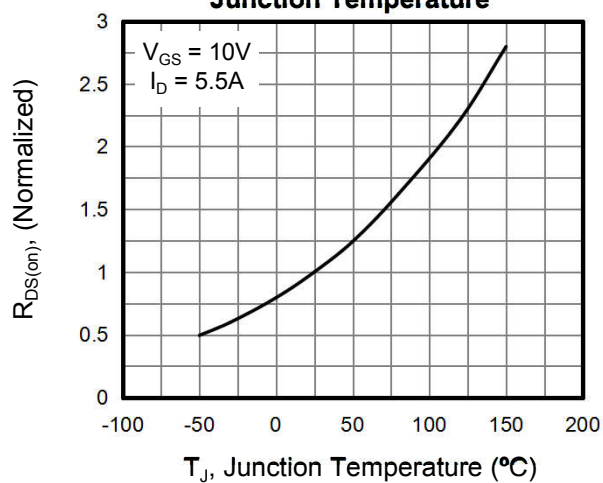


Figure 8. Threshold Voltage vs. Junction Temperature

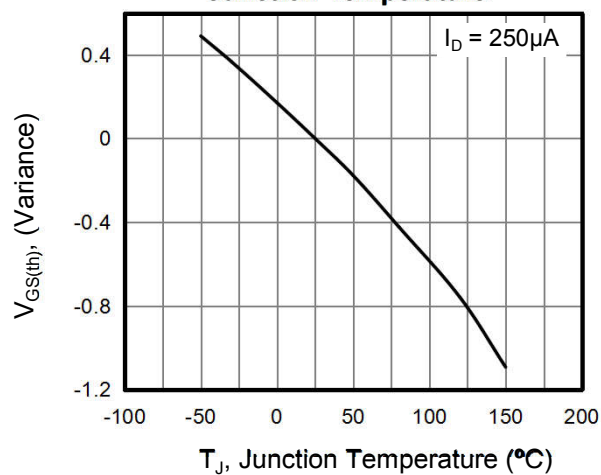
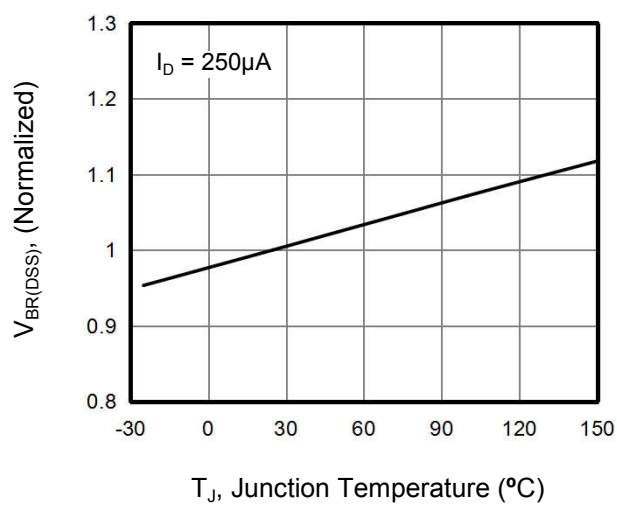


Figure 9. Breakdown voltage vs. Junction Temperature



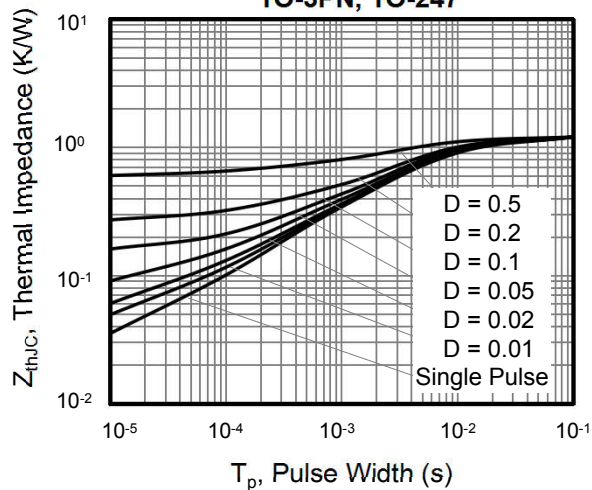
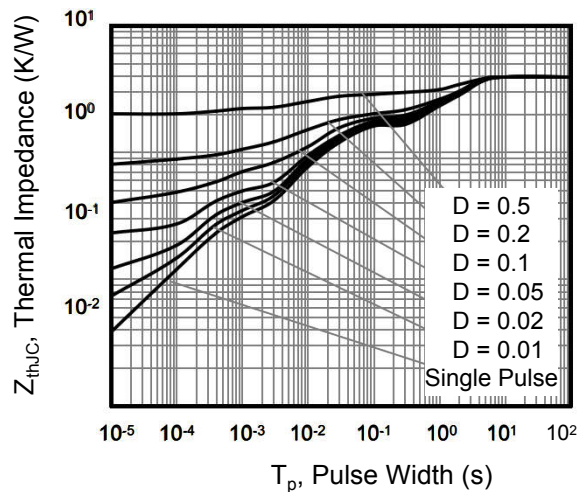
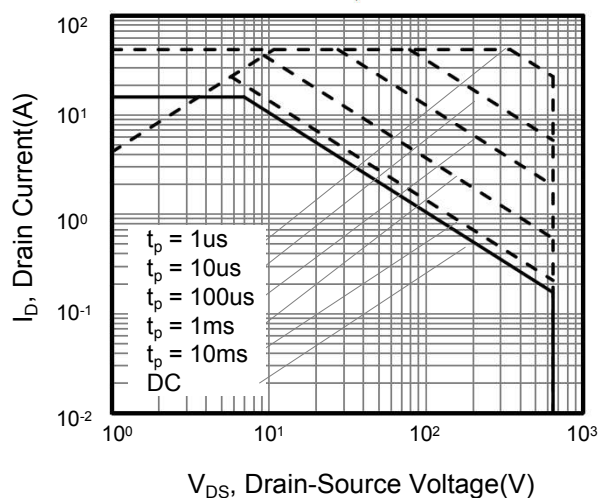
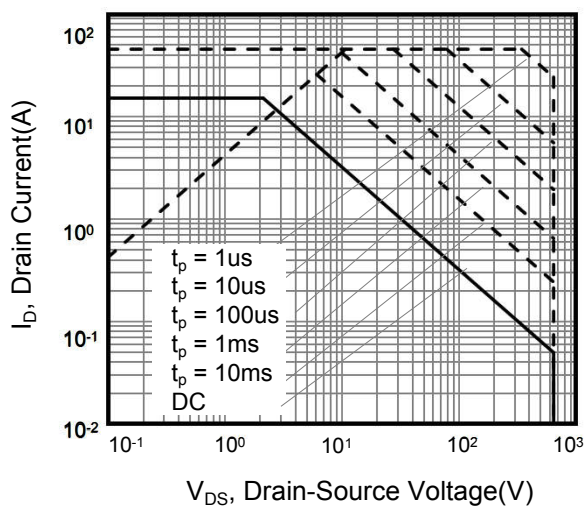
**Typical Characteristics** $T_J = 25^\circ\text{C}$, unless otherwise noted**Figure10 . Transient Thermal Impedance**
TO-263, TO-262, TO-220
TO-3PN, TO-247**Figure 11. Transient Thermal Impedance**
TO-220F**Figure 12. Safe operation area for**
TO-263, TO-262, TO-220
TO-3PN, TO-247**Figure 13. Safe operation area for**
TO-220F



Figure A: Gate Charge Test Circuit and Waveform

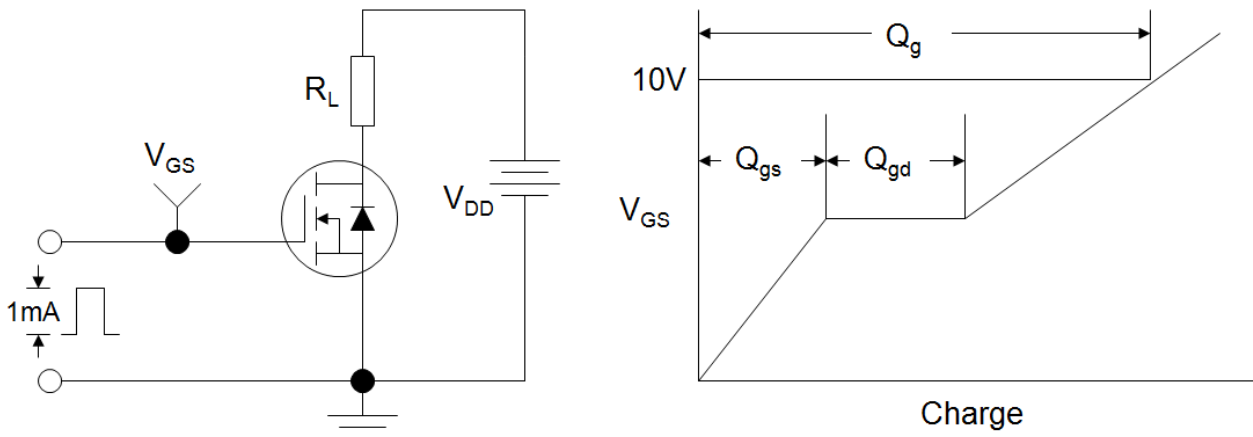


Figure B: Resistive Switching Test Circuit and Waveform

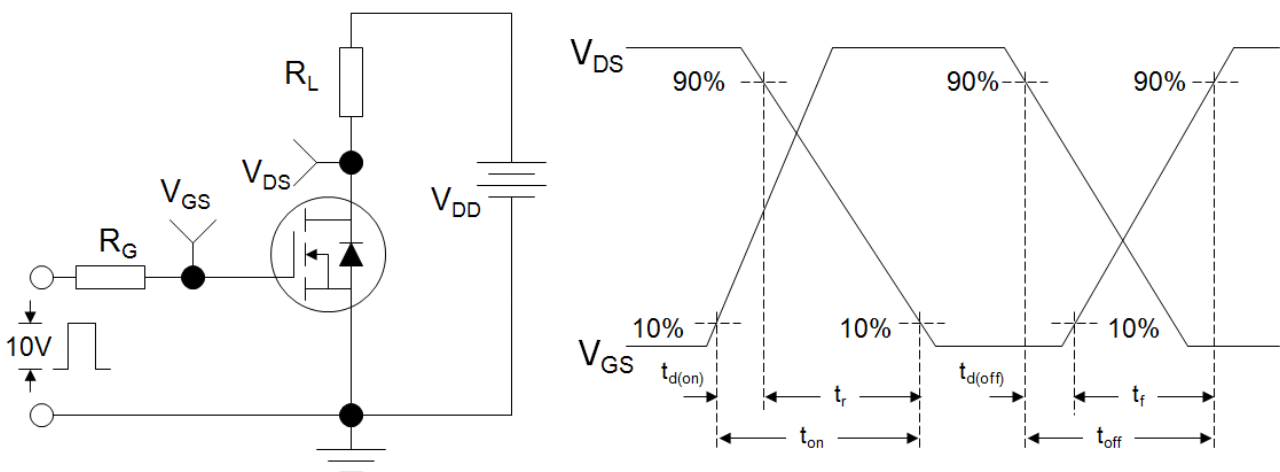
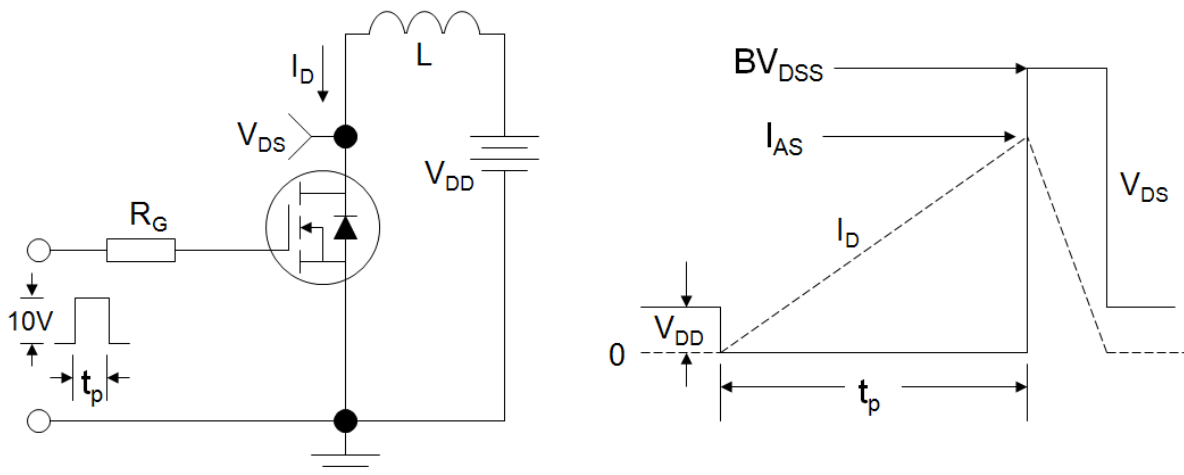
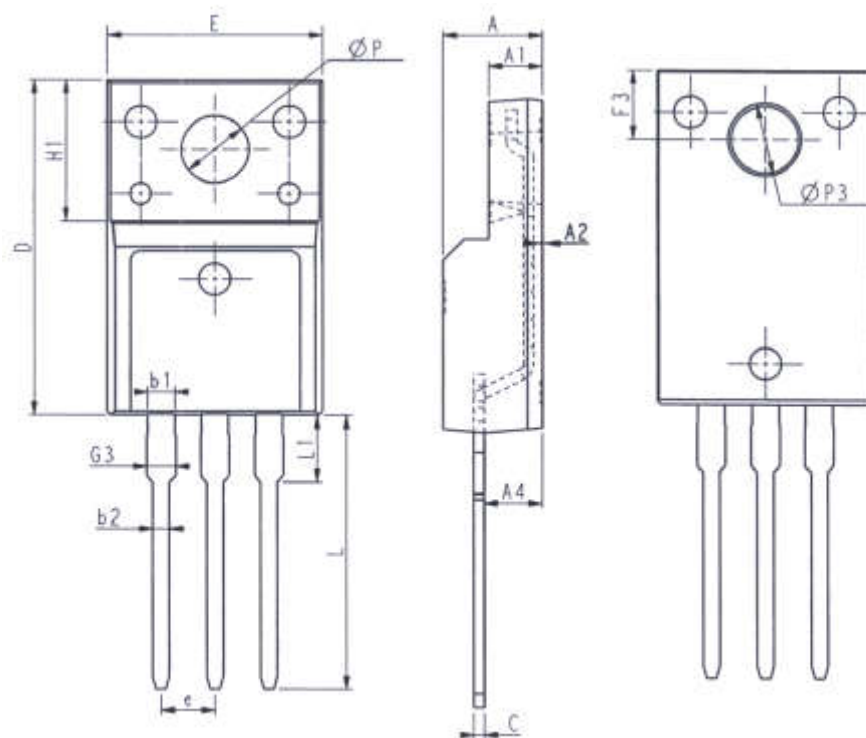


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





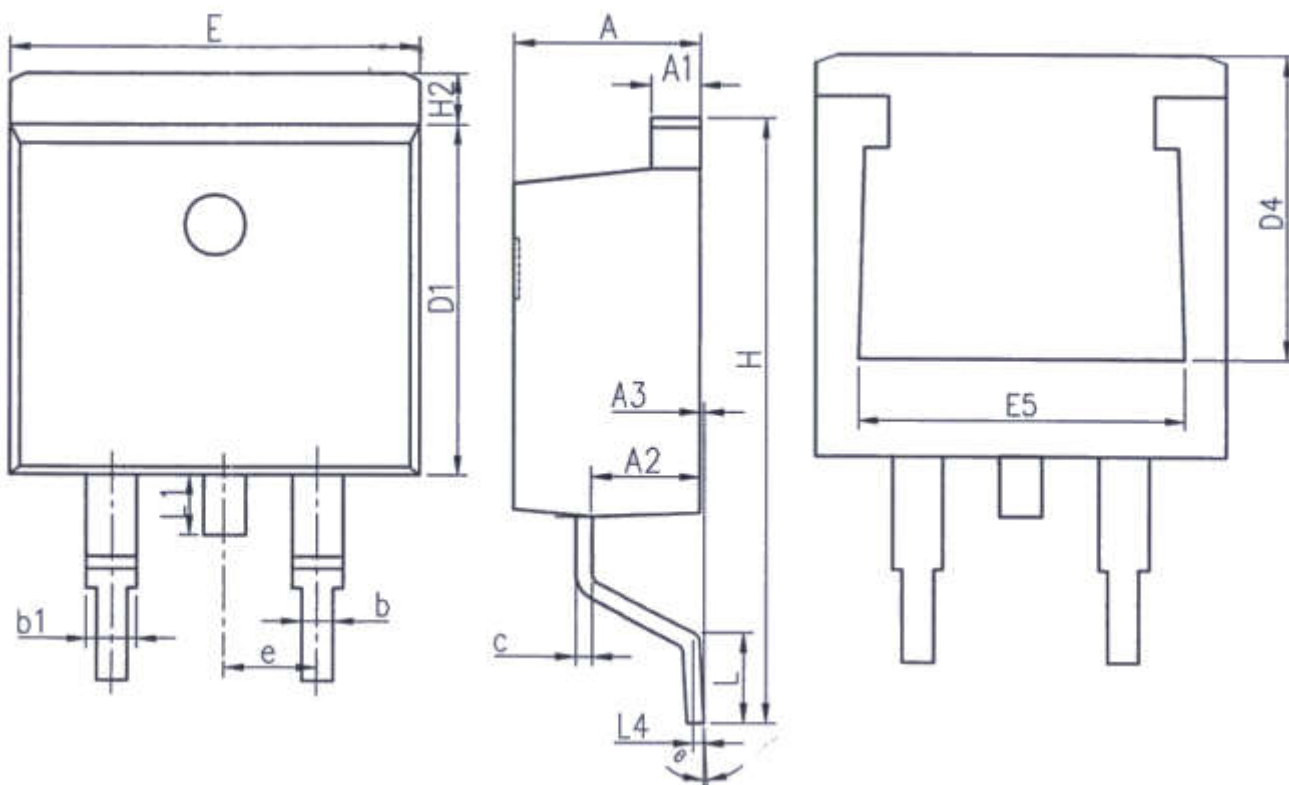
TO-220F



Unit: mm			Unit: mm		
Symbol	Min.	Max.	Symbol	Min.	Max.
E	9.96	10.36	L	12.68	13.28
A	4.50	4.90	L1	2.93	3.13
A1	2.34	2.74	P	3.03	3.38
A2	0.30	0.60	P3	3.15	3.65
A4	2.56	2.96	F3	3.15	3.45
c	0.40	0.65	G3	1.25	1.55
D	15.57	16.17	b1	1.18	1.43
H1	6.70REF		b2	0.70	0.95
e	2.54BSC				

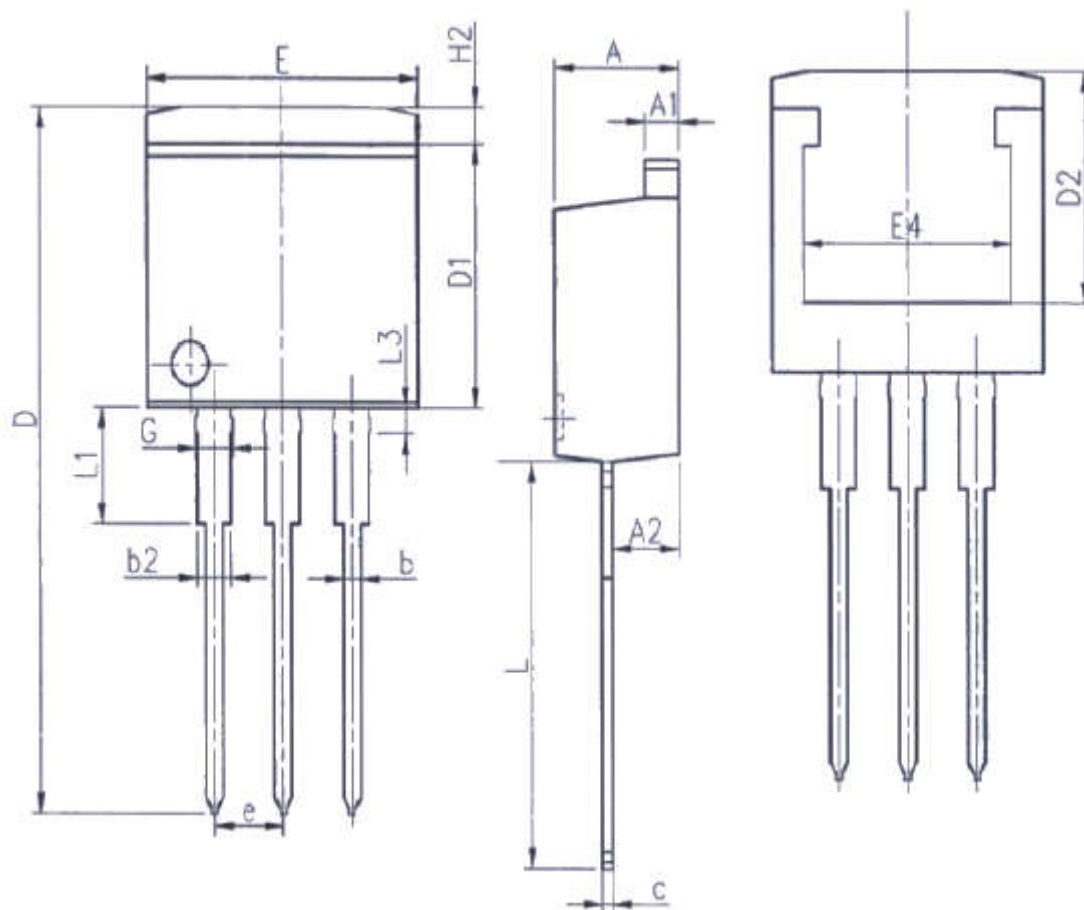


TO-263



Unit: mm		
Symbol	Min.	Max.
A	4.37	4.77
A1	1.22	1.42
A2	2.49	2.89
A3	0.00	0.25
b	0.70	0.96
b1	1.17	1.47
c	0.30	0.53
D1	8.50	8.90
D4	6.60	-

Unit: mm		
Symbol	Min.	Max.
E	9.86	10.36
E5	7.06	-
e	2.54BSC	
H	14.70	15.50
H2	1.07	1.47
L	2.00	2.60
L1	1.40	1.70
L4	0.25BSC	
θ	0°	9°

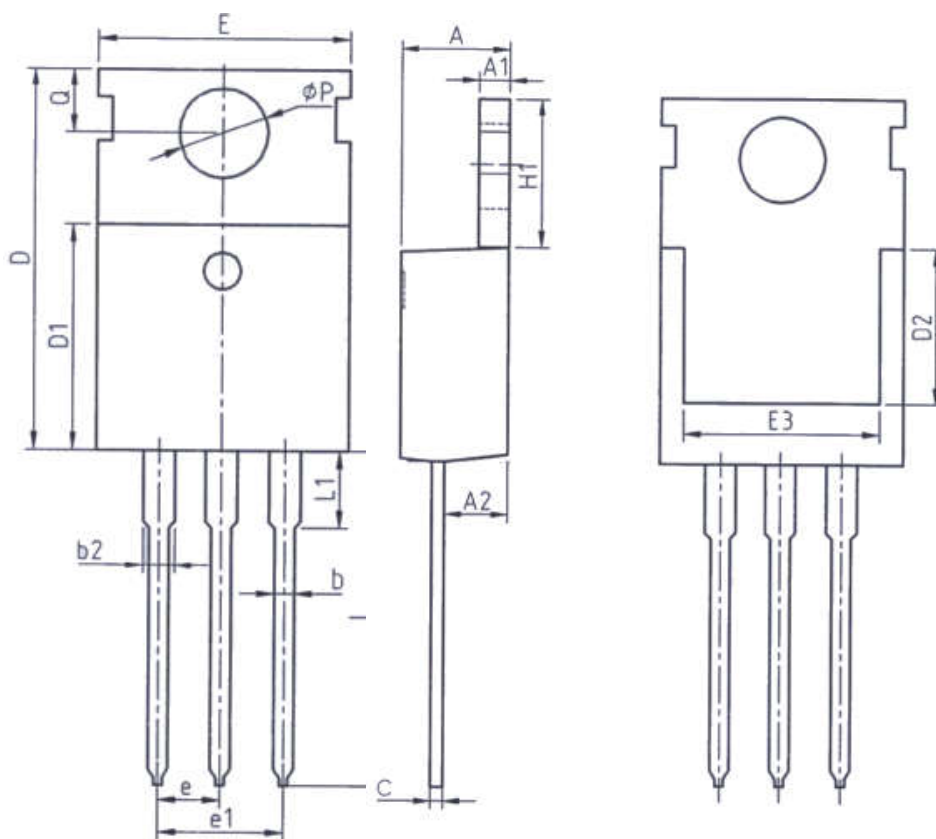
**TO-262**

Unit: mm		
Symbol	Min.	Max.
A	4.37	4.77
A1	1.22	1.42
A2	2.47	2.87
b	0.70	0.97
b2	1.17	1.42
c	0.28	0.53
D	23.20	24.02
D1	8.38	8.90
D2	6.00	-

Unit: mm		
Symbol	Min.	Max.
E	9.90	10.39
E4	7.30	-
e	2.54BSC	
G	1.25	1.50
H2	-	1.31
L	13.34	14.10
L1	3.30	4.06
L3	0.95	1.15



TO-220

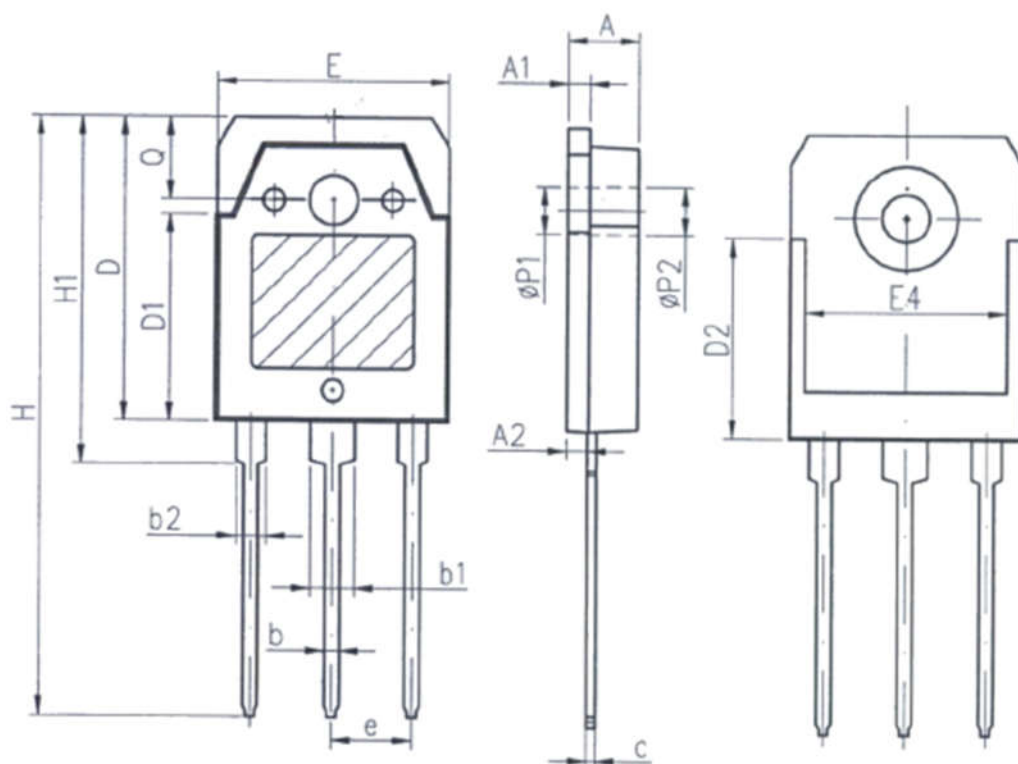


Unit: mm		
Symbol	Min.	Max.
A	4.37	4.77
A1	1.25	1.45
A2	2.20	2.60
b	0.70	0.95
b2	1.17	1.47
c	0.40	0.65
D	15.10	16.10
D1	8.80	9.40
D2	5.50	—

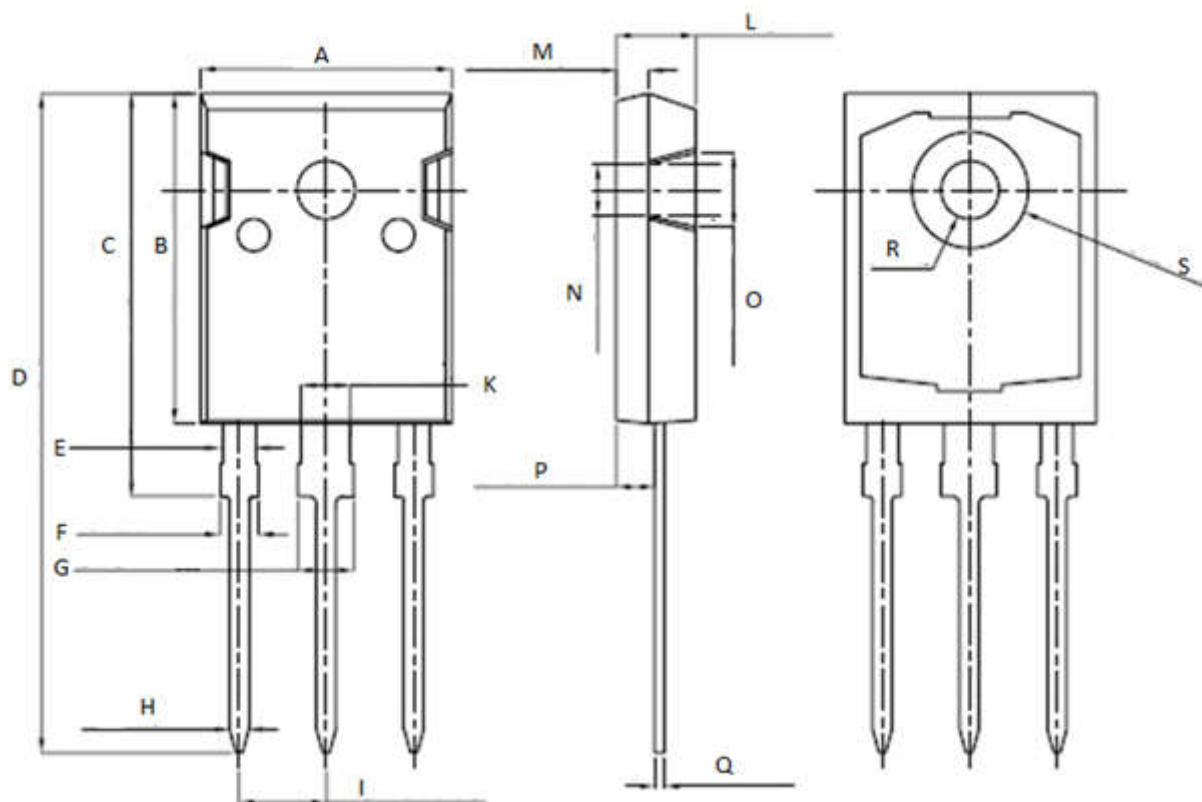
Unit: mm		
Symbol	Min.	Max.
E	9.70	10.30
E3	7.00	—
e	2.54BSC	
e1	5.08BSC	
H1	6.25	6.85
L	12.75	13.80
L1	—	3.40
P	3.40	3.80
Q	2.60	3.00



TO-3PN



Unit:mm		
Symbol	Min.	Max.
A	4.6	5
A1	1.4	1.65
A2	1.18	1.58
b	0.8	1.2
b1	2.8	3.2
b2	1.8	2.2
c	0.5	0.75
D	19.6	20.2
D1	13.55	14.25
D2	12.9REF	
E	15.35	15.85
E4	12.6	-
e	5.45TYP	
H	40.1	40.9
H1	23.15	23.65
P1	3.2REF	
P2	3.5REF	

**TO-247**

Unit: mm		
Symbol	Min.	Max.
A	15.95	16.25
B	20.85	21.25
C	20.95	21.35
D	40.5	40.9
E	1.9	2.1
F	2.1	2.25
G	3.1	3.25
H	1.1	1.3
I	5.40	5.50

Unit: mm		
Symbol	Min.	Max.
K	2.90	3.10
L	4.90	5.30
M	1.90	2.10
N	4.50	4.70
O	5.40	5.60
P	2.29	2.49
Q	0.51	0.71
R	$\phi 3.5$	$\phi 3.7$
S	$\phi 7.1$	$\phi 7.3$



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